

Notice of References Cited	Application/Control No. 10/524,022	Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
	Examiner Hoan H. Tran	Art Unit 2852	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,592,304	01-1997	Udagawa et al.	358/444
*	B	US-5,337,406	08-1994	Takakura et al.	715/520
	C	US-			
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	I	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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